

# MCP41XXX/42XXX

# Single/Dual Digital Potentiometer with SPI<sup>TM</sup> Interface

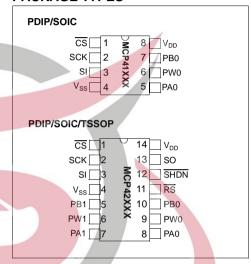
### **FEATURES**

- · 256 taps for each potentiometer
- Potentiometer values for  $10k\Omega$ ,  $50k\Omega$  and  $100k\Omega$
- Single and dual versions
- SPI serial interface (mode 0,0 and 1,1)
- +/- 1 LSB max INL & DNL
- Low power CMOS technology
- 1 μA maximum supply current in static operation
- Multiple devices can be daisy-chained together (MCP42XXX only)
- Shutdown feature open circuits of all resistors for maximum power savings
- Hardware shutdown pin available on MCP42XXX only
- Single supply operation (2.7V 5.5V)
- Industrial temperature range: -40°C to +85°C

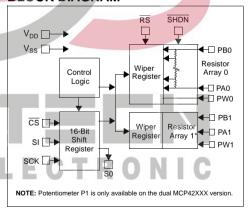
# **DESCRIPTION**

The MCP41XXX and MCP42XXX devices are 256 position digital potentiometers available in  $10k\Omega$ .  $50k\Omega$ . and 100kΩ resistance versions. The MCP41XXX is a single channel device and is offered in an 8-pin PDIP or SOIC package. The MCP42XXX contains two independent channels in a 14-pin PDIP, SOIC, or TSSOP package. The wiper position of the MCP41XXX/42XXX varies linearly and is controlled via an industry-standard SPI interface. The devices consume <1µA during static operation. A software shutdown feature is provided that disconnects the "A" terminal from the resistor stack and simultaneously connects the wiper to the "B" terminal. In addition, the dual MCP42XXX has a SHDN pin that performs the same function in hardware. During the shutdown mode, the contents of the wiper register can be changed and the potentiometer returns from shutdown to the new value. The wiper is reset to the mid-scale position, 80h, upon power-up. The RS (reset) pin implements a hardware reset and also returns the wiper to mid-scale. The MCP42XXX SPI interface includes both the SI and SO pins, allowing daisy-chaining of multiple devices. Channel-to-channel resistance matching on the MCP42XXX varies by less than 1%. These devices operate from a single 2.7 -5.5V supply and are specified over the extended industrial temperature range of -40°C to +85°C.

### **PACKAGE TYPES**



## **BLOCK DIAGRAM**



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#### 1.0 **ELECTRICAL CHARACTERISTICS**

# DC CHARACTERISTICS:10KΩ VERSION

fied operating ranges unless noted.			TYP.	MAX.	UNITS	V <sub>B</sub> = 0V, T <sub>A</sub> = +25°C CONDITIONS
PARAMETER	SYMBOL	MIN.	IYP.	MAX.	UNITS	CONDITIONS
Rheostat Mode		_				T=
Nominal Resistance	R	8	10	12	kΩ	T <sub>A</sub> = +25°C (Note 1)
Rheostat Differential Non Linearity	R-DNL	-1	±1/4	+1	LSB	Note 2
Rheostat Integral Non Linearity	R-INL	-1	±1/4	+1	LSB	Note 2
Rheostat Tempco	$\Delta R_{AB}/\Delta T$	_	800	_	ppm/°C	
Wiper Resistance	R <sub>W</sub>	_	52	100	Ω	$V_{DD} = 5.5 \text{ V}, I_W = 1 \text{ mA}, \text{ code } 00\text{h}$
Tripor recolciance	R <sub>W</sub>	_	73	125	Ω	$V_{DD} = 2.7 \text{ V}, I_W = 1 \text{ mA}, \text{ code } 00\text{h}$
Wiper Current	I <sub>W</sub>	-1	_	+1	mA	
Nominal Resistance Match	ΔR/R	_	0.2	1	%	MCP42010 only, P0 to P1;T <sub>A</sub> = 25°C
Potentiometer Divider						
Resolution	N	8	_	_	Bits	
Monotonicity	N	8		-	Bits	
Differential Non Linearity	DNL	-1	±1/4	+1	LSB	Note 3
ntegral Non Linearity	INL	-1	±1/4	+1	LSB	Note 3
Voltage Divider Tempco (Variation between both halves of the voltage divider)	ΔV <sub>W</sub> /ΔΤ	- >	1	_	ppm/°C	Code 80h
	V <sub>WFSE</sub>	-2	-0.7	0	LSB	Code FFh, V <sub>DD</sub> = 5V(Note 9)
Full Scale Error	V <sub>WFSE</sub>	-2	-0.7	0	LSB	Code FFh, V <sub>DD</sub> = 3V(Note 9)
	V <sub>WZSE</sub>	0	+0.7	+2	LSB	Code 00h, V <sub>DD</sub> = 5V( <b>Note 9</b> )
Zero Scale Error	V <sub>WZSE</sub>	0	+0.7	+2	LSB	Code 00h, V <sub>DD</sub> = 3V(Note 9)
Resistor Terminals	WZSE					,
Voltage Range	V <sub>A.B.W</sub>	0	_	V <sub>DD</sub>		Note 4
Capacitance (CA or CB)	A,B,**	_	15	_	pF	f =1MHz, Code = 80h, see Figure 2-30 for test circ
Capacitance (Cw)		_	5.6	_	pF	f =1MHz, Code = 80h, see Figure 2-30 for test circ
Dynamic Characteristics (Note 6)					<u> </u>	
Bandwidth -3dB	BW	_	1		MHz	V <sub>B</sub> = 0V, Measured at Code 80h,
						Output Load = 30PF  V = V = V = 0V +1% From Band, Transition from
Settling Time	t <sub>S</sub>		2	_	μS	V <sub>A</sub> = V <sub>DD</sub> , V <sub>B</sub> = 0V, ±1% Error Band, Transition from Code 00h to Code 80h, Output Load = 30pF
Resistor Noise Voltage	e <sub>NWB</sub>		9	_	nV/√Hz	V <sub>A</sub> = Open, Code 80h, f =1kHz
Crosstalk	C <sub>T</sub>	_	-95	-	dB	$V_A = V_{DD}$ , $V_B = 0V$ (Note 5)
Digital Inputs/Outputs (CS, SCK, SI, SC	) Note 10					
Schmitt Trigger High Level Input Voltage (All digital input pins) Schmitt Trigger Low Level Input Voltage	V <sub>IH</sub>	0.7V <sub>DD</sub>	_		V	
(All digital input pins)	V <sub>IL</sub>	_	_	0.3V <sub>DD</sub>	V	
Hysteresis of Schmitt Trigger Inputs	V <sub>HYS</sub>		0.05V <sub>DD</sub>	7/		
Low Level Output Voltage	V <sub>OL</sub>	7-1	-/-	0.40	V	$I_{OL} = 2.1 \text{ mA}, V_{DD} = 5V$
High Level Output Voltage	Voн	V <sub>DD</sub> - 0.5	$\lambda \neq -$	7 -	V	I <sub>OH</sub> = -400μA, V <sub>DD</sub> = 5V
Input Leakage Current	ILI	-1	- 7	1	μА	$\overline{\text{CS}} = \text{V}_{\text{DD}}, \text{ V}_{\text{IN}} = \text{V}_{\text{SS}} \text{ or V}_{\text{DD}},$ includes $\text{V}_{\text{A}}$ while SHDN = 0
Pin Capacitance (All inputs/outputs)	C <sub>IN</sub> , C <sub>OUT</sub>	- \	10	_	pF	V <sub>DD</sub> = 5.0V, T <sub>A</sub> = +25°C, f <sub>c</sub> = 1 MHz
Power Requirements						OTDONIC
Operating Voltage Range	V <sub>DD</sub>	2.7	_	5.5	V	CIKUNIC
Supply Current, Active	I <sub>DDA</sub>		340	500	μА	V <sub>DD</sub> = 5.5V, <del>CS</del> = V <sub>SS</sub> , t <sub>SCK</sub> = 10MHz, SO = Open, Code FFh ( <b>Note 7</b> )
Supply Current, Static	I <sub>DDS</sub>	_	0.01	1	μА	$\overline{CS}$ , $\overline{SHDN}$ , $\overline{RS} = V_{DD} = 5.5V$ , $SO = Open(Note 7)$
	PSS	_	0.0015	0.0035	%/%	$V_{DD} = 4.5V - 5.5V$ , $V_A = 4.5V$ , Code 80h
Power Supply Sensitivity	PSS					
	200	_	0.0015	0.0035	%/%	V <sub>DD</sub> = 2.7V - 3.3 V, V <sub>A</sub> = 2.7V, Code 80h

Figure 2-25. We pin where the voltage on the adjacent  $V_W$  pin is swinging full scale. All dynamic characteristics use  $V_{DD}$  = 5V. Supply current is independent of current through the potentiometers. TSSOP devices are only specified at 25°C and 85°C. See Figure 2-25 for test circuit.

See Figure 2-12 for RS and SHDN pin operation.

where the final metal in the final metal is the deviation in an inear value fleasured between the mathematical and the infillment resistance where positions. R-DNL measures the relative step change from the ideal between successive tap positions.  $I_W = 50\mu A$  for  $V_{DD} = 3V$  and  $I_W = 400\mu A$  for  $V_{DD} = 5V$  for  $10k\Omega$  version. See Figure 2-26 for test circuit.

INL and DNL are measured at  $V_W$  with the device configured in the voltage divider or potentiometer mode.  $V_A = V_{DD}$  and  $V_B = 0V$ . DNL specification limits of  $\pm 1$  LSB max are specified monotonic operating conditions. See Figure 2-25 for test circuit.

Resistor terminals A,B and W have no restrictions on polarity with respect to each other. Full scale and zero scale error were measured using Figure 2-25.

# DC CHARACTERISTICS: 50KΩ VERSION

All parameters apply across the specified operating ranges unless noted.	Industrial (I): \ Typical specifi	V <sub>DD</sub> = +2.7V ications repre	to 5.5V T <sub>A</sub> = esent values	-40°C to +85 for V <sub>DD</sub> = 5\	5°C ( <b>Note 8</b> /, V <sub>SS</sub> = 0V,	V <sub>B</sub> = 0V, T <sub>A</sub> = +25°C
PARAMETER	SYMBOL	MIN.	TYP.	MAX.	UNITS	CONDITIONS
Rheostat Mode			1	1	I	
Nominal Resistance	R	35	50	65	kΩ	T <sub>A</sub> = +25°C ( <b>Note 1</b> )
Rheostat Differential Non Linearity	R-DNL	-1	±1/4	+1	LSB	Note 2
Rheostat Integral Non Linearity	R-INL	-1	±1/4	+1	LSB	Note 2
Rheostat Tempco	ΔR <sub>AB</sub> /ΔΤ	_	800		ppm/°C	
·	R <sub>W</sub>	_	125	175	Ω	V <sub>DD</sub> = 5.5 V, I <sub>W</sub> = 1 mA, code 00h
Wiper Resistance	R <sub>W</sub>	_	175	250	Ω	V <sub>DD</sub> = 2.7 V, I <sub>W</sub> = 1 mA, code 00h
Wiper Current	I <sub>W</sub>	-1		+1	mA	
Nominal Resistance Match	ΔR/R		0.2	1	%	MCP42050 only, P0 to P1; T <sub>Δ</sub> = 25°C
Potentiometer Divider						
Resolution	N	8		_	Bits	
Monotonicity	N	8	_		Bits	
Differential Non Linearity	DNL	-1	± 1/4	+1	LSB	V <sub>DD</sub> = 5V (Note 3)
Integral Non Linearity	INL	-1	±1/4	+1	LSB	Note 3
Voltage Divider Tempco (Variation between both halves of the voltage divider)	$\Delta V_W/\Delta T$	_	1	-	ppm/°C	Code 80h
Full Cools From	V <sub>WFSE</sub>	-1	-0.25	0	LSB	Code FFh, V <sub>DD</sub> = 5V ( <b>Note 9</b> )
Full Scale Error	V <sub>WFSE</sub>	-1	-0.35	0	LSB	Code FFh, V <sub>DD</sub> = 3V ( <b>Note 9</b> )
Zana Osala Essas	V <sub>WZSE</sub>	0	+0.25	+1	LSB	Code 00h, V <sub>DD</sub> = 5V ( <b>Note 9</b> )
Zero Scale Error	V <sub>WZSE</sub>	0	+0.35	+1	LSB	Code 00h, V <sub>DD</sub> = 3V (Note 9)
Resistor Terminals						
Voltage Range	$V_{A,B,W}$	0	-	V <sub>DD</sub>		Note 4
Capacitance (CA or CB)		_	11		pF	f =1MHz, Code = 80h, see Figure 2-30 for test cir- cuit
Capacitance (Cw)		_	5.6	-	pF	f =1MHz, Code = 80h, see Figure 2-30 for test cir- cuit
Dynamic Characteristics (Note 6)						
Bandwidth -3dB	BW	_	280	-	kHz	V <sub>B</sub> = 0V, Measured at Code 80h, Output Load = 30PF
Settling Time	t <sub>S</sub>	_	8	_	μS	V <sub>A</sub> = V <sub>DD</sub> , V <sub>B</sub> = 0V, ±1% Error Band, Transition from Code 00h to Code 80h, Output Load = 30pF
Resistor Noise Voltage	e <sub>NWB</sub>	_	20		nV/√Hz	V <sub>A</sub> = Open, Code 80h, f =1kHz
Crosstalk	C <sub>T</sub>	_	-95		dB	$V_A = V_{DD}$ , $V_B = 0V$ (Note 5)
Digital Inputs/Outputs (CS, SCK, SI, SO) No	te 10					
Schmitt Trigger High Level Input Voltage (All digital input pins)	V <sub>IH</sub>	0.7V <sub>DD</sub>	_	_	V	
Schmitt Trigger Low Level Input Voltage (All digital input pins)	V <sub>IL</sub>	_	ı	0.3V <sub>DD</sub>	V	
Hysteresis of Schmitt Trigger Inputs	V <sub>HYS</sub>	_	0.05V <sub>DD</sub>	_		
Low Level Output Voltage	V <sub>OL</sub>		-//	0.40	V	I <sub>OL</sub> = 2.1 mA, V <sub>DD</sub> = 5V
High Level Output Voltage	V <sub>OH</sub>	V <sub>DD</sub> - 0.5	7		V	I <sub>OH</sub> = -400μA, V <sub>DD</sub> = 5V
Input Leakage Current	I <sub>LI</sub>	-1	7-	1	μА	$\overline{\text{CS}} = V_{\text{DD}}, V_{\text{IN}} = V_{\text{SS}} \text{ or } V_{\text{DD}},$ includes $V_{\text{A}}$ while SHDN = 0
Pin Capacitance (All inputs/outputs)	C <sub>IN</sub> , C <sub>OUT</sub>		10	_	pF	$V_{DD} = 5.0V, T_A = +25^{\circ}C, f_C = 1 \text{ MHz}$
Power Requirements						
Operating Voltage Range	V <sub>DD</sub>	2.7		5.5	CV	$V_{DD} = 5.5V$ , $\overline{CS} = V_{SS}$ , $f_{SCK} = 10MHz$ ,
Supply Current, Active	I <sub>DDA</sub>	_	340	500	μА	SO = Open, Code FFh ( <b>Note 7</b> )
			0.04	-		CS, SHDN, RS = V <sub>DD</sub> = 5.5V, SO = Open (Note 7)
Supply Current, Static	I <sub>DDS</sub>	_	0.01	1	μΑ	CS, SHDN, RS = V <sub>DD</sub> = 5.5V, SO = Open ( <b>Note 7</b> )
Supply Current, Static  Power Supply Sensitivity	I <sub>DDS</sub> PSS	_	0.001	0.0035	μA %/%	$V_{DD} = 4.5V - 5.5V$ , $V_{A} = 4.5V$ , Code 80h

- 2: Rheostat position non linearity R-INL is the deviation from an ideal value measured between the maximum resistance and the minimum resistance wiper positions. R-DNL measures the relative step change from the ideal between successive tap positions.  $I_W = V_{DD}/R$  for +3V or +5V for the  $50k\Omega$ version. See Figure 2-26 for test circuit.
- INL and DNL are measured at  $V_{\rm M}$  with the device configured in the voltage divider or potentiometer mode.  $V_{\rm A}$  =  $V_{\rm DD}$  and  $V_{\rm B}$  = 0V. DNL specification limits of ±1 LSB max are specified monotonic operating conditions. See Figure 2-25 for test circuit.
- Resistor terminals A,B and W have no restrictions on polarity with respect to each other. Full scale and zero scale error were measured using Figure 2-25.
- Measured at  $V_W$  pin where the voltage on the adjacent  $V_W$  pin is swinging full scale.
- All dynamic characteristics use V<sub>DD</sub> = 5V.
  Supply current is independent of current through the potentiometers.
- TSSOP devices are only specified at 25°C and 85°C.
- See Figure 2-25 for test circuit.
- 10: See Figure 2-12 for RS and SHDN pin operation.

# DC CHARACTERISTICS OF 100K $\Omega$ VERSION

PARAMETER   SYMBOL   MIN.   TYP.   MAX.   UNITS   CONDITIONS	All parameters apply across the specified operating ranges unless noted.	Industrial (I): Y					
Nominal Resistance   R   70   100   13							
Rheostat Differential Non Linearity         R-DNL         -1         ±1/4         +1         LSB         Note 2           Rheostat Integral Non Linearity         R-INL         -1         ±1/4         +1         LSB         Note 2           Rheostat Tempoo         AR <sub>Nd</sub> /T         -800         -         ppm°C         C           Wiper Resistance         R <sub>W</sub> -         175         250         Ω         V <sub>Do</sub> = 5.5 V, I <sub>W</sub> = 1 mA, code 00h           Wiper Current         I <sub>W</sub> -1         -         +1         mA         W <sub>Do</sub> = 2.7 V, I <sub>W</sub> = 1 mA, code 00h           Nominal Resistance Match         AR/R         -         0.2         1         %         MCP42100 only, P0 to P1/T <sub>A</sub> = 25°C           Potentiometer Divider         -         -         Bits         MCP42100 only, P0 to P1/T <sub>A</sub> = 25°C           Potentiometer Divider         -         -         Bits         MCP42100 only, P0 to P1/T <sub>A</sub> = 25°C           Potentiometer Divider         -         -         Bits         MCP42100 only, P0 to P1/T <sub>A</sub> = 25°C           Potentiometer Divider         -         -         -         Bits         MCP0210 Note 30           Differential Non Linearity         DNL         -1         ±1/4         +1         LSB         N	Rheostat Mode						
Recistat Differential Non Linearity   R-DNL   -1   ±1/4   +1   LSB   Note 2	Nominal Resistance	R	70	100	130	kΩ	T <sub>A</sub> = +25°C ( <b>Note 1</b> )
Rheostat Tempoo	Rheostat Differential Non Linearity	R-DNL	-1	±1/4	+1	LSB	
R <sub>W</sub>	Rheostat Integral Non Linearity	R-INL	-1	±1/4	+1	LSB	Note 2
Wigher Resistance   Rw     175   250   Ω   V <sub>DD</sub> = 2.7 V, I <sub>W</sub> = 1 mA, code 00h	Rheostat Tempco	$\Delta R_{AB}/\Delta T$	_	800	_	ppm/°C	
New Fore Current   New   -1     +1   mA   McP42100 only, P0 to P1, T <sub>A</sub> = 25°C	Minor Projetono	R <sub>W</sub>	_	125	175	Ω	V <sub>DD</sub> = 5.5 V, I <sub>W</sub> = 1 mA, code 00h
Nominal Resistance Match	wiper Resistance	R <sub>W</sub>	_	175	250	Ω	V <sub>DD</sub> = 2.7 V, I <sub>W</sub> = 1 mA, code 00h
Potentiometer Divider   Resolution   N	Wiper Current	I <sub>W</sub>	-1	_	+1	mA	
Resolution   N   8	Nominal Resistance Match	ΔR/R	-	0.2	1	%	MCP42100 only, P0 to P1;T <sub>A</sub> = 25°C
Monotonicity	Potentiometer Divider						
Differential Non Linearity   DNL	Resolution	N	8		I	Bits	
Integral Non Linearity	Monotonicity	N	8	_	_	Bits	
Voltage Divider Tempco (Variation between both halves of the voltage divider)   ΔV <sub>W</sub> /ΔT	Differential Non Linearity	DNL	-1	±1/4	+1	LSB	V <sub>DD</sub> = 5V (Note 3)
Doth halves of the voltage divider    Doth halves of Schmitt Trigger Low Level (Input Voltage (All digital input pins)   View Down Alexandre (All inputs/outputs)   View Down Alexandre (A	-	INL	-1	±1/4	+1	LSB	Note 3
VWFSE		$\Delta V_W/\Delta T$	_	1	_ :=	ppm/°C	Code 80h
Vwrse	Full Scale Error	V <sub>WFSE</sub>	-1	-0.25	0	LSB	Code FFh, V <sub>DD</sub> = 5V (Note 9)
Vwzse	Full Scale Errol	V <sub>WFSE</sub>	/-1	-0.35	0	LSB	Code FFh, V <sub>DD</sub> = 3V (Note 9)
Voltage Range   VA,B,W   O   Capacitance (CA or CB)   Capacitance (CA or CB)   Capacitance (CA or CB)   Capacitance (CA or CB)   Capacitance (CM)   Capacitance (CA)   Capacitance (C	Zero Scale Error	V <sub>WZSE</sub>	0	+0.25	+1	LSB	Code 00h, V <sub>DD</sub> = 5V ( <b>Note 9</b> )
Voltage Range	Zelo Scale Elloi	V <sub>WZSE</sub>	0	+0.35	+1	LSB	Code 00h, V <sub>DD</sub> = 3V ( <b>Note 9</b> )
Capacitance (CA or CB)         —         111         —         pF         f=1MHZ, Code = 80h, see Figure 2-30 fc cuit           Capacitance (CW)         —         5.6         —         pF         cf=1MHZ, Code = 80h, see Figure 2-30 fc cuit           Dynamic Characteristics (Note 6)           Bandwidth -3dB         BW         —         145         —         kHz         Vg = 0V, Measured at Code 80h, Output Load = 30pF           Settling Time         Is         —         18         —         μS         V <sub>x</sub> = V <sub>DD</sub> , V <sub>g</sub> = 0V, ±1% Error Band, Transito Code 00h to Code 80h, Output Load = 30pF           Resistor Noise Voltage         e <sub>NWB</sub> —         29         —         nV/-Hz         V <sub>x</sub> = V <sub>DD</sub> , V <sub>g</sub> = 0V, ±1% Error Band, Transito Code 00h to Code 80h, Output Load = 30pF           Resistor Noise Voltage         e <sub>NWB</sub> —         29         —         nV/-Hz         V <sub>x</sub> = V <sub>DD</sub> , V <sub>g</sub> = 0V, (Note 5)           Digital Inputs/Outputs (CS, SCK, SI, SO) Note 10           Schmitt Trigger High Level Input Voltage (All digital input pins)         V <sub>I</sub> 0.7V <sub>DD</sub> —         V           Schmitt Trigger Input Voltage (All digital input pins)         V <sub>I</sub> —         0.05V <sub>DD</sub> V           Hysteresis of Schmitt Trigger Inputs         V <sub>I</sub> —	Resistor Terminals						
Capacitance (CA or Us)         —         11         —         PP         cuit           Capacitance (CW)         —         5.6         —         pF         f=1MHz, Code = 80h, see Figure 2-30 fc cuit           Dynamic Characteristics (Note 6)           Bandwidth -3dB         BW         —         145         —         kHz         Vg = 0V, Measured at Code 80h, Output Load = 30pF           Settling Time         ts         —         18         —         μS         Vg = Vop.Vg = 0V, ±1% Error Band, Transito Code 80h, Output Load = 30pF           Resistor Noise Voltage         eNWB         —         29         —         nV/HZ         VA = Open, Code 80h, ElkHz           Crosstalk         CT         —         -95         —         dB         VA = VpD, VB = 0V (Note 5)           Digital Inputs/Outputs (CS, SCK, SI, SO) Note 10           Schmitt Trigger Input Voltage (All digital input pins)         VH         0.7VpD         —         V           Schmitt Trigger Input Voltage (All digital input pins)         VHYS         —         0.05VpD         —           Low Level Output Voltage         VOL         —         —         0.40         V         IoL = 2.1 mA, VpD = 5V           High Level Output Voltage         VOH         VpD	Voltage Range	$V_{A,B,W}$	0	_	$V_{DD}$		
Capacitance (CW)         —         5.6         —         pF         I = 1/IHALZ, Code = 80h, see Figure 2-30 fc cuit           Dynamic Characteristics (Note 6)           Bandwidth -3dB         BW         —         145         —         kHz         Vg = 0V, Measured at Code 80h, Output Load = 30pF           Settling Time         Is         —         18         —         μS         V <sub>2</sub> = V <sub>DD</sub> , V <sub>3</sub> = 0V, ±1% Error Band, Transito Code 60h to Code 80h, Output Load = 30pF           Resistor Noise Voltage         e <sub>NWB</sub> —         29         —         nV/-/HZ         V <sub>A</sub> = Open, Code 80h, f = 1kHz           Crosstalk         C <sub>T</sub> —         -95         —         dB         V <sub>A</sub> = V <sub>DD</sub> , V <sub>B</sub> = 0V (Note 5)           Digital Inputs/Outputs (CS, SCK, SI, SO) Note 10           Schmitt Trigger High Level Input Voltage (All digital input pins)           V <sub>I</sub> H         0.7V <sub>DD</sub> —         —         V           Schmitt Trigger Input Voltage (All digital input pins)         V <sub>I</sub> —         —         V           Hysteresis of Schmitt Trigger Inputs         V <sub>HYS</sub> —         0.05V <sub>DD</sub> —         V           Low Level Output Voltage         V <sub>OL</sub> —         —         0.40         V         I <sub>OL</sub> = 2.1 mA, V <sub>DD</sub> =	Capacitance (CA or CB)		_	11		pF	f=1MHz, Code = 80h, see Figure 2-30 for test cir-
Dynamic Characteristics (Note 6)	Capacitance (Cw)		_	5.6	_	pF	f=1MHz, Code = 80h, see Figure 2-30 for test cir
Bandwidth -3dB	Dynamic Characteristics (Note 6)					1	Cult
Settling Time   Settling Ti	Bandwidth -3dB	BW	_	145	_	kHz	V <sub>B</sub> = 0V, Measured at Code 80h,
Resistor Noise Voltage	Settling Time	t <sub>S</sub>	_	18		μS	V <sub>A</sub> = V <sub>DD</sub> , V <sub>B</sub> = 0V, ±1% Error Band, Transition from
Crosstalk   C <sub>T</sub>   -95   - dB   V <sub>A</sub> = V <sub>DD</sub> , V <sub>B</sub> = 0V (Note 5)	Resistor Noise Voltage	e <sub>NWB</sub>		29	_	nV/√Hz	
Schmitt Trigger High Level Input Voltage (All digital input pins)  Schmitt Trigger Low Level Input Voltage (All digital input pins)  Vih 0.7V_DD - V  0.3V_DD V  Hysteresis of Schmitt Trigger Inputs VHYS - 0.05V_DD - U  Low Level Output Voltage VOL - 0.400 V IOL = 2.1 mA, VDD = 5V  High Level Output Voltage VOH VDD = 0.5 - V IOH = -400 $\mu$ A, VDD = 5V  Input Leakage Current ILL -1 - 1 $\mu$ A	Crosstalk		_	-95	-	dB	$V_A = V_{DD}$ , $V_B = 0V$ (Note 5)
digital input pins)         V <sub>IH</sub> 0.7V <sub>DD</sub> —         V           Schmitt Trigger Low Level (nput Voltage (All digital input pins)         V <sub>IL</sub> —         0.3V <sub>DD</sub> V           Hysteresis of Schmitt Trigger Inputs         V <sub>HYS</sub> —         0.05V <sub>DD</sub> —           Low Level Output Voltage         V <sub>OL</sub> —         —         0.40         V         I <sub>OL</sub> = 2.1 mA, V <sub>DD</sub> = 5V           High Level Output Voltage         V <sub>OH</sub> V <sub>DD</sub> = 0.5         —         —         V         I <sub>OH</sub> = -400µA, V <sub>DD</sub> = 5V           Input Leakage Current         I <sub>LI</sub> -1         —         1         µA         CS = V <sub>DD</sub> , V <sub>IN</sub> = V <sub>SS</sub> or V <sub>DD</sub> , includes V <sub>A</sub> , while SHDN = 0           Pin Capacitance (All inputs/outputs)         C <sub>IN</sub> , C <sub>OUT</sub> —         10         —         pF         V <sub>DD</sub> = 5.0V, T <sub>A</sub> = +25°C, f <sub>c</sub> = 1 MHz           Power Requirements           Operating Voltage Range         V <sub>DD</sub> 2.7         —         5.5         V	Digital Inputs/Outputs (CS, SCK, SI, SO) No	te 10					
Schmitt Trigger Low Level (Input Voltage (All digital input pins)         V <sub>IL</sub> —         0.3V <sub>DD</sub> V           Hysteresis of Schmitt Trigger Inputs         V <sub>HYS</sub> —         0.05V <sub>DD</sub> —         —           Low Level Output Voltage         V <sub>OL</sub> —         —         0.40         V         I <sub>OL</sub> = 2.1 mA, V <sub>DD</sub> = 5V           High Level Output Voltage         V <sub>OH</sub> V <sub>DD</sub> = 0.5         —         —         V         I <sub>OH</sub> = -400µA, V <sub>DD</sub> = 5V           Input Leakage Current         I <sub>LI</sub> -1         —         1         µA         CS = V <sub>DD</sub> , V <sub>IN</sub> = V <sub>SS</sub> or V <sub>DD</sub> includes V <sub>A</sub> while SHDN = 0           Pin Capacitance (All inputs/outputs)         C <sub>IN</sub> , C <sub>OUT</sub> —         10         —         pF         V <sub>DD</sub> = 5.0V, T <sub>A</sub> = +25°C, f <sub>c</sub> = 1 MHz           Power Requirements           Operating Voltage Range         V <sub>DD</sub> 2.7         —         5.5         V		V <sub>IH</sub>	0.7V <sub>DD</sub>	_		V	
Hysteresis of Schmitt Trigger Inputs	Schmitt Trigger Low Level Input Voltage (All	V <sub>IL</sub>	_	_	0.3V <sub>DD</sub>	V	
$ \begin{array}{c ccccccccccccccccccccccccccccccccccc$		V <sub>HYS</sub>	_	0.05V <sub>DD</sub>	_		
High Level Output Voltage     V <sub>OB</sub> - 0.5     —     V $t_{OH} = .400 \mu A$ , $V_{DD} = 5 V$ Input Leakage Current     I <sub>LI</sub> -1     —     1 $\mu A$ $\frac{CS}{CS} = V_{DD}, V_{IN} = V_{SS}$ or $V_{DD}$ includes $V_A$ while $\frac{SHDN}{SHDN} = 0$ Pin Capacitance (All inputs/outputs)     C <sub>IN</sub> , C <sub>OUT</sub> —     10     —     pF $V_{DD} = 5.0V$ , $T_A = +25^{\circ}C$ , $f_c = 1$ MHz       Power Requirements       Operating Voltage Range     V <sub>DD</sub> 2.7     —     5.5     V	Low Level Output Voltage		7-		0.40	V	I <sub>OL</sub> = 2.1 mA,V <sub>DD</sub> = 5V
$ \begin{array}{c ccccccccccccccccccccccccccccccccccc$			V <sub>DD</sub> - 0.5	/	-	V	I <sub>OH</sub> = -400μA, V <sub>DD</sub> = 5V
Pin Capacitance (All inputs/outputs)         C <sub>IN</sub> , C <sub>OUT</sub> —         10         —         pF         V <sub>DD</sub> = 5.0V, T <sub>A</sub> = +25°C, f <sub>c</sub> = 1 MHz           Power Requirements           Operating Voltage Range         V <sub>DD</sub> 2.7         —         5.5         V	Input Leakage Current	ILI	-1	/ -/	1	μА	CS = V <sub>DD</sub> , V <sub>IN</sub> = V <sub>SS</sub> or V <sub>DD</sub> ,
Power Requirements           Operating Voltage Range         V <sub>DD</sub> 2.7         —         5.5         V	Pin Capacitance (All inputs/outputs)	C <sub>IN</sub> , C <sub>OUT</sub>	_	10		pF	
	Power Requirements			7			
	Operating Voltage Range	V <sub>DD</sub>	2.7		5.5	V	TRONIC
Supply Current, Active IDDA — 340 500 µA VDD = 5.5V, CS = VSs, ISCK = 10MHZ,			\ _	340	500	μА	$V_{DD} = 5.5V$ , $\overline{CS} = V_{SS}$ , $f_{SCK} = 10MHz$ ,
SO = Open, Code Frn (Note 7)						·	SO = Open, Code FFn (Note 7)  CS, SHDN, RS = V <sub>DD</sub> = 5.5V, SO = Open (Note 7)
PSS — 0.0015 0.0035 %/% V <sub>DD</sub> = 4.5V - 5.5V, V <sub>A</sub> = 4.5V Code 80h			_			<u> </u>	
Power Supply Sensitivity  PSS — 0.0015 0.0035 %/% V <sub>DD</sub> = 2.7V - 3.3V, V <sub>A</sub> = 2.7V Code 80h	Power Supply Sensitivity		_				

Note

- V<sub>AB</sub> = V<sub>DD</sub>, no connection on wiper.

  Rheostat position non linearity R-INL is the deviation from an ideal value measured between the maximum resistance and the minimum resistance wiper positions. R-DNL measures the relative step change from the ideal between successive tap positions. I<sub>W</sub> = V<sub>DD</sub>/R for +3V or +5V for the  $100k\Omega$  version. See Figure 2-26 for test circuit.
- INL and DNL are measured at V<sub>W</sub> with the device configured in the voltage divider or potentiometer mode. V<sub>A</sub> = V<sub>DD</sub> and V<sub>B</sub> = 0V. DNL specification limits of ±1 LSB max are specified monotonic operating conditions. See Figure 2-25 for test circuit.

  Resistor terminals A,B and W have no restrictions on polarity with respect to each other. Full scale and zero scale error were measured using
- Figure 2-25.
- Measured at  $V_W$  pin where the voltage on the adjacent  $V_W$  pin is swinging full scale.
- All dynamic characteristics use  $V_{DD} = 5V$ .
- Supply current is independent of current through the potentiometers. TSSOP devices are only specified at 25°C and 85°C See Figure 2-25 for test circuit.

- 10: See Figure 2-12 for RS and SHDN pin operation.

# **ELECTRICAL CHARACTERISTICS (CONTINUED)**

### Maximum Ratings\*

V <sub>DD</sub>	7.0V
All inputs and outputs w.r.t. V <sub>SS</sub>	-0.6V to V <sub>DD</sub> +1.0V
Storage temperature	60°C to +150°C
Ambient temp. with power applied	60°C to +125°C
ESD protection on all pins	≥ 2 kV

<sup>\*</sup>Notice: Stresses above those listed under "maximum ratings" may cause permanent damage to the device. This is a stress rating only and functional operation of the device at those or any other conditions above those indicated in the operational listings of this specification is not implied. Exposure to maximum rating conditions for extended periods may affect device reliability.

# **AC TIMING CHARACTERISTICS**

All parameters apply across the specified operating ranges unless otherwise noted.	Industrial (I	): V <sub>DD</sub> = +	-2.7V to 5	5.5V TA =	-40°C to +	85°C
PARAMETER	SYMBOL	MIN.	TYP.	MAX.	UNITS	CONDITIONS
Clock Frequency	F <sub>CLK</sub>	_	_	10	MHz	V <sub>DD</sub> = 5V ( <b>Note 1</b> )
Clock High Time	t <sub>HI</sub>	40		_	ns	
Clock Low Time	t <sub>LO</sub>	40	_	_	ns	
CS Fall to First Rising CLK Edge	t <sub>CSSR</sub>	40	_	_	ns	
Data Input Setup Time	tsu	40		_	ns	
Data Input Hold Time	t <sub>HD</sub>	10	_	_	ns	
SCK Fall to SO Valid Propagation Delay	t <sub>DO</sub>		_	80	ns	CL = 30pF (Note 2)
SCK Rise to CS Rise Hold Time	t <sub>CHS</sub>	30		-	ns	
SCK Rise to CS Fall Delay	t <sub>CS0</sub>	10	- /	_	ns	
CS Rise to CLK Rise Hold	t <sub>CS1</sub>	100	_	_ /	ns	
CS High Time	tcsh	40	_	-/	ns	
Reset Pulse Width	t <sub>RS</sub>	150		/-/	ns	Note 2
RS Rising to CS Falling Delay Time	t <sub>RSCS</sub>	150		-4	ns	Note 2
CS rising to RS or SHDN falling delay time	t <sub>SE</sub>	40	_	<u> </u>	ns	Note 3
CS low time	t <sub>CSL</sub>	100	_	-	ns	Note 3
Shutdown Pulse Width	t <sub>SH</sub>	150		_ ^	ns	Note 3

Note 1: When using the device in the daisy chain configuration, max. clock frequency is determined by a combination of propagation delay time (t<sub>DO</sub>) and data input setup time (t<sub>SU</sub>). Max. clock frequency is therefore ~ 5.8MHz based on SCK rise and fall times of 5ns, t<sub>HI</sub> = 40ns, t<sub>DO</sub> = 80 ns and t<sub>SU</sub> = 40ns.

Note 2: Applies only to the MCP42XXX devices.

Note 3: Applies only when using hardware pins to exit software shutdown mode, MCP42XXX only.



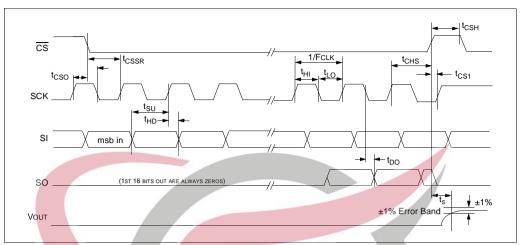


Figure 1-1: Detailed Serial interface Timing

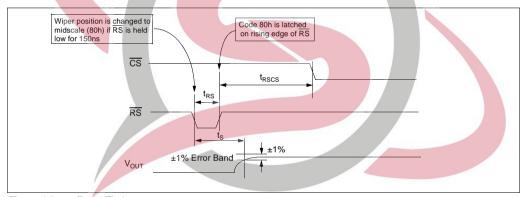


Figure 1-2: Reset Timing

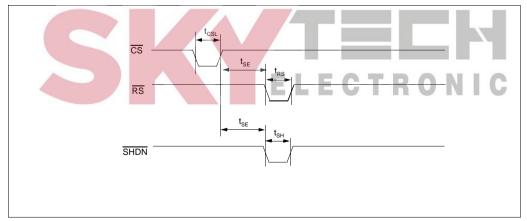


Figure 1-3: Software Shutdown Exit Timing

# 2.0 TYPICAL PERFORMANCE CURVES

**Note:** Unless otherwise indicated, curve represents 10kΩ, 50kΩ, and 100kΩ devices,  $V_{DD}$  = 5V,  $V_{SS}$  = 0V,  $T_{A}$  = 25°C,  $V_{B}$  = 0V.

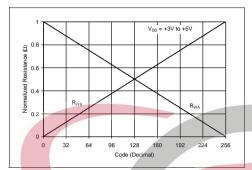
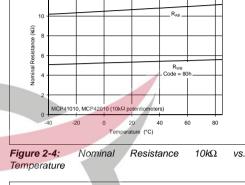


Figure 2-1: Normalized Wiper to End Terminal Resistance vs. Code



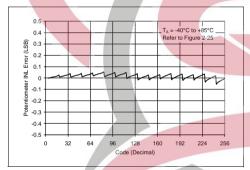
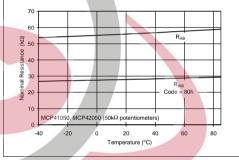


Figure 2-2: Potentiometer INL Error vs. Code



**Figure 2-5:** Nominal Resistance  $50k\Omega$  vs. Temperature

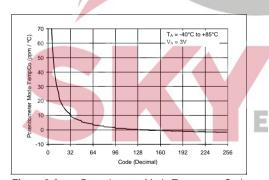
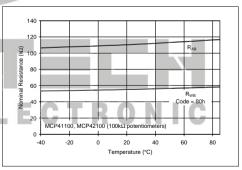


Figure 2-3: Potentiometer Mode Tempco vs. Code



**Figure 2-6:** Nominal Resistance 100k $\Omega$  vs Temperature

# MCP41XXX/42XXX

Note: Unless otherwise indicated, curve represents 10k $\Omega$ , 50k $\Omega$ , and 100k $\Omega$  devices, V<sub>DD</sub> = 5V, V<sub>SS</sub> = 0V, T<sub>A</sub> = 25°C, V<sub>B</sub> = 0V.

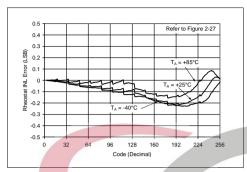


Figure 2-7: Rheostat INL Error vs. Code

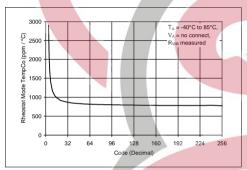


Figure 2-8: Rheostat Mode Tempco vs. Code

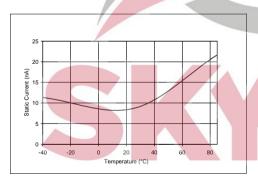


Figure 2-9: Static Current vs. Temperature

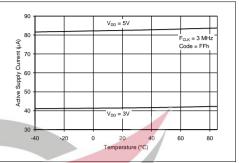


Figure 2-10: Active Supply Current vs. Temperature

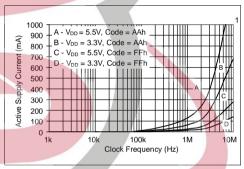


Figure 2-11: Active Supply Current vs. Clock Frequency

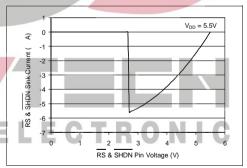


Figure 2-12: Reset & Shutdown Pins Current vs. Voltage

Note: Unless otherwise indicated, curve represents 10k $\Omega$ , 50k $\Omega$ , and 100k $\Omega$  devices, V<sub>DD</sub> = 5V, V<sub>SS</sub> = 0V, T<sub>A</sub> = 25°C, V<sub>B</sub> = 0V.

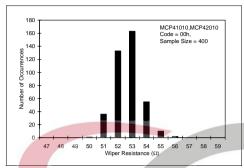


Figure 2-13: 10kΩ Device Wiper Resistance Histogram

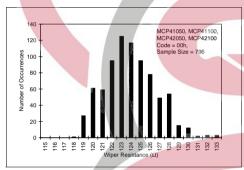
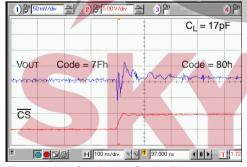


Figure 2-14: 50kΩ, 100kΩ Device Wiper Resistance Histogram



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Figure 2-15: One Position Settling Time

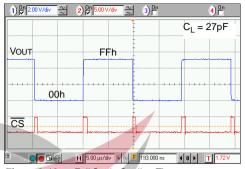


Figure 2-16: Full Scale Settling Time

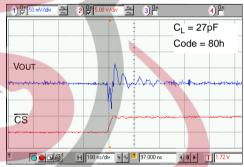
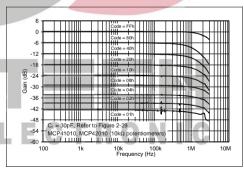


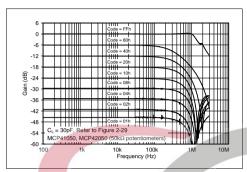
Figure 2-17: Digital Feedthrough vs. Time



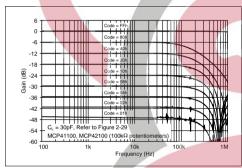
**Figure 2-18:** Gain vs. Frequency for 10kΩ Potentiometer

# MCP41XXX/42XXX

**Note:** Unless otherwise indicated, curve represents 10k $\Omega$ , 50k $\Omega$ , and 100k $\Omega$  devices, V<sub>DD</sub> = 5V, V<sub>SS</sub> = 0V, T<sub>A</sub> = 25°C, V<sub>B</sub> = 0V.



**Figure 2-19:** Gain vs. Frequency for  $50k\Omega$  Potentiometer



**Figure 2-20:** Gain vs. **Frequency for** 100k $\Omega$  Potentiometer

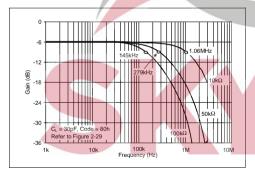


Figure 2-21: -3 dB Bandwidths

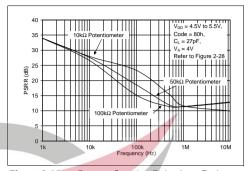


Figure 2-22: Power Supply Rejection Ratio vs. Frequency

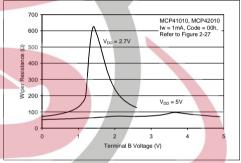
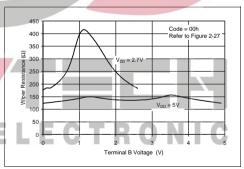


Figure 2-23: 10kΩ Wiper Resistance vs. Voltage



**Figure 2-24:** 50kΩ & 100kΩ Wiper Resistance vs. Voltage

# 2.1 Parametric Test Circuits

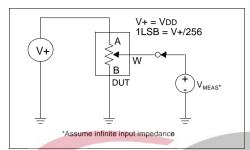


Figure 2-25: Potentiometer Divider Non-Linearity Error Test Circuit (DNL, INL)

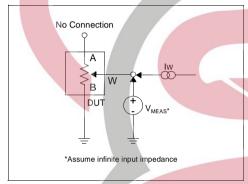


Figure 2-26: Resistor Position Non-Linearity Error Test Circuit (Rheostat operation DNL, INL)

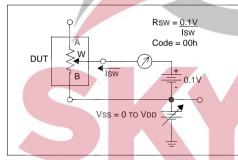


Figure 2-27: Wiper Resistance Test Circuit

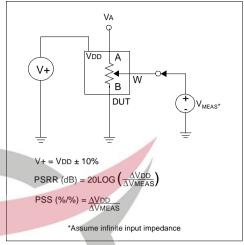


Figure 2-28: Power Supply Sensitivity Test Circuit (PSS, PSRR)

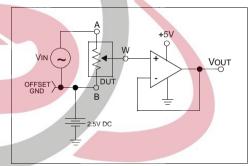


Figure 2-29: Gain vs. Frequency Test Circuit

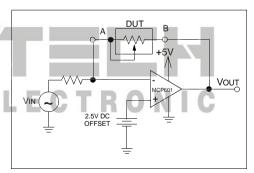


Figure 2-30: Capacitance Test Circuit

## 3.0 PIN DESCRIPTIONS

### PA0. PA1

Potentiometer Terminal A Connection.

# **PB0, PB1**

Potentiometer Terminal B Connection.

# PW0, PW1

Potentiometer Wiper Connection.

# **CS** Chip Select

This is the SPI port chip select pin and is used to execute a new command after it has been loaded into the shift register. This pin has a Schmitt Trigger input.

#### SCK Serial Clock

This is the SPI port clock pin and is used to clock in new register data. Data is clocked into the SI pin on the rising edge of the clock and out the SO pin on the falling edge of the clock. This pin is gated to the CS pin, i.e., the device will not draw any more current if the SCK pin is toggling when the CS pin is high. This pin has a Schmitt Trigger input.

# SI Serial Data Input

This is the SPI port serial data input pin. The command and data bytes are clocked into the shift register using this pin. This pin is gated to the  $\overline{CS}$  pin, i.e., the device will not draw any more current if the SI pin is toggling when the  $\overline{CS}$  pin is high. This pin has a Schmitt Trigger input.

# SO Serial Data Output (MCP42XXX devices only)

This is the SPI port serial data output pin used for daisy chaining more than one device. Data is clocked out of the SO pin on the falling edge of clock. This is a pushpull output and does not go to a high impedance state when  $\overline{CS}$  is high. It will drive a logic low when  $\overline{CS}$  is high.

## RS Reset (MCP42XXX devices only)

The Reset pin will set all potentiometers to mid-scale (Code 80h) if this pin is brought low for at least 150ns. This pin should not be toggled low when the  $\overline{\text{CS}}$  pin is low. It is possible to toggle this pin when the  $\overline{\text{SHDN}}$  pin is low. In order to minimize power consumption, this pin has an active pull-up circuit. The performance of this circuit is shown in Figure 2-12. This pin will draw negligible current at logic level 0 and logic level 1.

# SHDN Shutdown (MCP42XXX devices only)

The Shutdown pin has a Schmit Trigger input. Pulling this pin low will put the device in a power saving mode where A terminal is opened and the B and W terminals are connected for all potentiometers. This pin should not be toggled low when the  $\overline{CS}$  pin is low. In order to minimize power consumption, this pin has an active pull-up circuit. The performance of this circuit is shown in Figure 2-12. This pin will draw negligible current at logic level 0 and logic level 1.

		MCP41XXX PINS						
PIN #	NAME	FUNCTION						
1	CS	Chip Select						
2	SCK	Serial Clock						
3	SI	Serial Data Input						
4	$V_{SS}$	Ground						
5	PA0	Terminal A Connection For Pot 0						
6	PW0	Wiper Connection For Pot 0						
7	PB0	Terminal B Connection For Pot 0						
8	$V_{DD}$	Power						

			MCP42XXX PINS
	PIN #	NAME	FUNCTION
	1	CS	Chip Select
	2	SCK	Serial Clock
	3	SI	Serial Data Input
	4	V <sub>ss</sub>	Ground
	5	PB1	Terminal B Connection For Pot 1
	6	PW1	Wiper Connection For Pot 1
1	7	PA1	Terminal A Connection For Pot 1
	8	PA0	Terminal A Connection For Pot 0
	9	PW0	Wiper Connection For Pot 0
	10	PB0	Terminal B Connection For Pot 0
	11	RS	Reset Input
	12	SHDN	Shutdown Input
	13	SO	Data Out for Daisy Chaining
	14	$V_{DD}$	Power

### 4.0 APPLICATIONS INFORMATION

The MCP41XXX/42XXX devices are 256 tap single and dual digital potentiometers that can be used in place of standard mechanical pots. Resistance values of  $10k\Omega$ ,  $50k\Omega$  and  $100k\Omega$  are available. As shown in Figure 4-1, each potentiometer is made up of a variable resistor and an 8-bit (256 position) data register that determines the wiper position. There is a nominal wiper resistance of  $52\Omega$  for the  $10k\Omega$  version and  $125\Omega$  for the  $50k\Omega$  and  $100k\Omega$  versions. For the dual devices, the channel to channel matching variation is less than 1%. The resistance between the wiper and either of the resistor endpoints varies linearly according to the value stored in the data register. Code 00h effectively con-

nects the wiper to the B terminal. At power up, all data registers will automatically be loaded with the midscale value, 80h. The serial interface provides the means for loading data into the shift register which is then transferred to the data registers. The serial interface also provides the means to place individual potentiometers in the shutdown mode for maximum power savings. The SHDN pin can also be used to put all potentiometers in shutdown mode and the RS pin is provided to set all potentiometers to mid-scale, 80h.

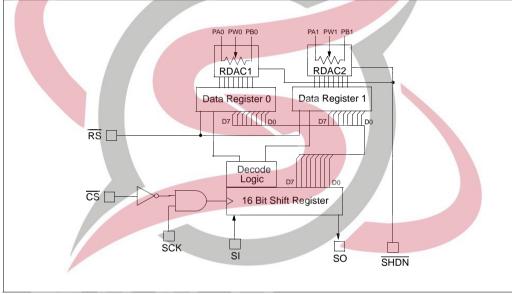
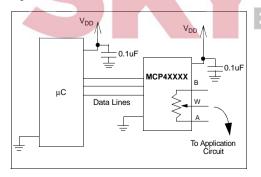


Figure 4-1: Block diagram showing the MCP42XXX dual digital potentiometer. Data register 0 and data register 1 are 8-bit registers allowing 256 tap positions for each wiper. Standard SPI pins are used with the addition of the Shutdown (SHDN) and Reset (RS) pins. As shown, reset affects the data register and wipers, bringing them to midscale. Shutdown disconnects the A terminal and connects the wiper to B, without changing the state of the data registers.



When laying out the circuit for your digital potentiometer, bypass capacitors should be used. These capacitors should be placed as close as possible to the device pin. A bypass capacitor value of 0.1  $\mu\text{F}$  is recommended. Digital and analog traces should be separated as much as possible on the board, and no traces should run underneath the device or the bypass capacitor. Extra precautions should be taken to keep traces with high frequency signals (such as clock lines) as far as possible from analog traces. Use of an analog ground plane is recommended in order to keep the ground potential the same for all devices on the board.

# 4.1 Modes of Operation

Digital potentiometer applications can be divided up into two categories: rheostat mode and potentiometer or voltage divider mode.

#### 4.1.1 RHEOSTAT MODE

In the rheostat mode, the potentiometer is used as a two terminal resistive element. The unused terminal should be tied to the wiper as shown in Figure 4-2. Note that reversing the polarity of the A and B terminals will not affect operation.

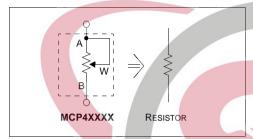


Figure 4-2: Two terminal or rheostat configuration for the digital potentiometer. Acting as a resistive element in the circuit, resistance is controlled by changing the wiper setting.

Using the device in this mode allows control of the total resistance between the two nodes. The total measured resistance would be the least at code 00h, where the wiper is tied to the B terminal. The resistance at this code is equal to the wiper resistance, typically  $52\Omega$  for the  $10k\Omega$  devices (MCP4X010),  $125\Omega$  for the  $50k\Omega$  (MCP4X050), and  $100k\Omega$  (MCP4X100) devices. For the  $10k\Omega$  device, the LSB size would be  $39.0625\Omega$  (assuming  $10k\Omega$  total resistance). The resistance would then increase with this LSB size until the total measured resistance at code FFh would be  $9985.94\Omega$ . The wiper will never directly connect to the A terminal of the resistor stack.

In the 00h state, the total resistance is the wiper resistance. To avoid damage to the internal wiper circuitry in this configuration, care should be taken to insure the current flow never exceeds 1mA.

For dual devices, the variation of channel-to-channel matching of the total resistance from A to B is less than 1%. The device-to-device matching however can vary up to 30%. In the rheostat mode, the resistance has a positive temperature coefficient. The change in wiper-to-end terminal resistance over temperature is shown in Figure 2-8. The most variation over temperature will occur in the first 6% of codes (code 00h to 0Fh) due to the wiper resistance coefficient affecting the total resistance. The remaining codes are dominated by the total resistance tempco R<sub>AB</sub>, typically 800 ppm/°C.

#### 4.1.2 POTENTIOMETER MODE

In the potentiometer mode, all three terminals of the device are tied to different nodes in the circuit. This allows the potentiometer to output a voltage proportional to the input voltage. This mode is sometimes called voltage divider mode. The potentiometer is used to provide a variable voltage by adjusting the wiper position between the two endpoints as shown in Figure 4-3. Note that reversing the polarity of the A and B terminals will not affect operation.

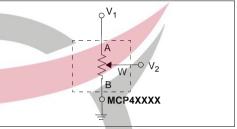


Figure 4-3: Three terminal or voltage divider mode

In this configuration, the ratio of the internal resistances define the temperature coefficient of the device. The resistor matching of the  $R_{\text{NB}}$  resistor to the  $R_{\text{AB}}$  resistor performs with a typical temperature coefficient of 1 ppm/°C (measured at code 80h). At lower codes, the wiper resistance temperature coefficient will dominate. Figure 2-3 shows the effect of the wiper. Above the lower codes, this figure shows that 70% of the states will typically have a temperature coefficient of less than 5 ppm/°C. 30% of the states will typically have a ppm/ °C of less than 1.

#### 4.2 Typical Applications

# 4.2.1 PROGRAMMABLE SINGLE ENDED AMPLIFIERS

Potentiometers are often used to adjust system reference levels or gain. Programmable gain circuits using digital potentiometers can be realized in a number of different ways. An example of a single supply inverting gain amplifier is shown in Figure 4-4. Due to the high input impedance of the amplifier, the wiper resistance is not included in the transfer function. For a single supply non-inverting gain configuration, the circuit in Figure 4-5 can be used.

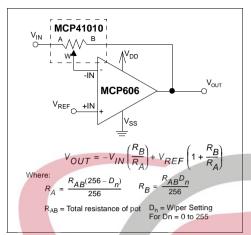


Figure 4-4: Single supply programmable inverting gain amplifier using a digital potentiometer.

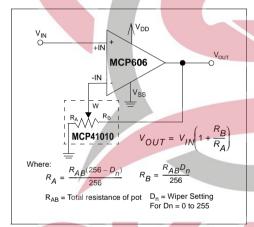


Figure 4-5: Single Supply Programmable Noninverting gain amplifier

In order for these circuits to work properly, care must be taken in a few areas. For linear operation, the analog input and output signals must be in the range of Vss to V<sub>DD</sub> for the potentiometer and input and output rails of the op-amp. The circuit in Figure 4-4 requires a virtual ground or reference input to the non-inverting input of the amplifier. Refer to Application Note AN-682, "Using Single Supply Operational Amplifiers in Embedded Systems" for more detail. At power up or reset (RS), the resistance is set to mid-scale and R and R<sub>p</sub> match. Based on the transfer function for the circuit, the gain is -1 V/V. As the code is increased and the wiper moves towards the A terminal and the gain increases. Conversely, when the wiper is moved towards the B terminal, the gain decreases. Figure 4-6 shows this relationship. Notice the pseudo-logarithmic gain around decimal code 128. As the wiper

approaches either terminal, the step size in the gain calculation increases dramatically. Due to the mismatched ratio of  $R_A$  and  $R_B$  at the extreme high and low codes, small increments in wiper position can dramatically affect the gain. As shown in Figure 4-3, recommended gains lie between 0.1 and 10 V/V.

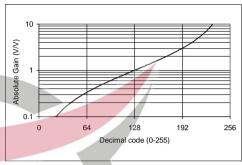


Figure 4-6: Gain vs. Code for inverting and differential amplifier circuits.

# 4.2.2 PROGRAMMABLE DIFFERENTIAL AMPLIFIER

An example of a differential input amplifier using digital potentiometers is shown in Figure 4-7. For the transfer function to hold, both pots must be programmed to the same code. The resistor matching from channel-to-channel within a dual device can be used as an advantage in this circuit. This circuit will also show stable operation over temperature due to the low potentiometer temperature coefficient. Figure 4-6 also shows the relationship between gain and code for this circuit. As the wiper approaches either terminal, the step size in the gain calculation increases dramatically. This circuit is recommended for gains between 0.1 and 10 V/V.



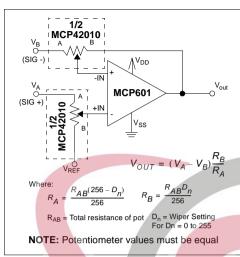
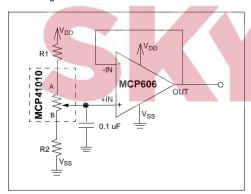


Figure 4-7: Single Supply programmable differential amplifier using digital potentiometers.

#### 4.2.3 PROGRAMMABLE OFFSET TRIM

For applications requiring only a programmable voltage reference, the circuit in Figure 4-8 can be used. This circuit shows the device used in the potentiometer mode along with two resistors and a buffered output. This creates a circuit with a linear relationship between voltage out and programmed code. Resistors R1 and R2 can be used to increase or decrease the output voltage step size. The potentiometer in this mode is stable over temperature. The operation of this circuit over temperature is shown in Figure 2-3. The worst performance over temperature will occur at the lower codes due to the dominating wiper resistance. R1 and R2 can also be used to affect the boundary voltages thereby eliminating the use of these lower codes.



**Figure 4-8:** By changing the values of R1 and R2, the voltage output resolution of this programmable voltage reference circuit is affected.

#### 4.3 Calculating Resistances

When programming the digital potentiometer settings, the following equations can be used to calculate the resistances. Programming code 00h effectively brings the wiper to the B terminal, leaving only the wiper resistance. Programming higher codes will bring the wiper closer to the A terminal of the potentiometer. The equations in Figure 4-9 can be used to calculate the terminal resistances. Figure 4-10 shows an example calculation using a 10kΩ potentiometer.

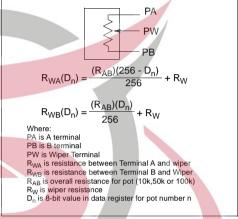


Figure 4-9: Potentiometer resistances are a function of code. It should be noted that when using these equations for most feedback amplifier circuits (see Figure 4-4 and Figure 4-5), the wiper resistance can be omitted due to the high impedance input of the amplifier.

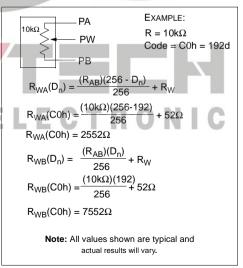


Figure 4-10: Example Resistance calculations.

### 5.0 SERIAL INTERFACE

Communications from the controller to the MCP41XXX/42XXX digital potentiometers is done using the SPI serial interface. This interface allows three commands:

- Write a new value to the potentiometer data register(s).
- Cause a channel to enter low power shutdown mode.
- 3. NOP (No Operation) command.

Executing any command is done by setting  $\overline{CS}$  low, and then clocking in a command byte followed by a data byte into the 16-bit shift register. The command is executed when  $\overline{CS}$  is raised. Data is clocked in on the rising edge of clock and out the SO pin on the falling edge of the clock. See Figure 5-1. The device will track the number of clocks (rising edges) while  $\overline{CS}$  is low and will abort all commands if the number of clocks is not a multiple of 16.

### 5.1 Command Byte

The first byte sent is always the command byte, followed by the data byte. The command byte contains two command select bits and two potentiometer select bits. Unused bits are don't care bits. The command select bits are summarized in Figure 5-2. The command select bits C1 and C0 (bits 4:5) of the command byte determine which command will be executed. If the command bits are both 0's or 1's, then a NOP command will be executed after all 16 bits have been loaded. This command is useful when using the daisychain configuration. When the command bits are 0,1 a write command will be executed with the 8 bits sent in the data byte. The data will be written to the potentiometer(s) determined by the potentiometer select bits. If the command bits are 1,0 then a shutdown command will be executed on the potentiometers determined by the potentiometer select bits.

For the MCP42XXX devices, the potentiometer select bits P1 and P0 (bits 0:1) determine which potentiometers are to be acted upon by the command. A corresponding one in the position signifies that the command for that potentiometer will get executed and a zero signifies that the command will not effect that potentiometer. See Figure 5-2.

### 5.2 Writing Data Into Data Registers

When new data is written into one or more of the potentiometer data registers, the write command is followed by the data byte for the new value. The command select bits C1, C0 are set to 0,1. The potentiometer selection bits P1 and P0 allow new values to be written to potentiometer 0, potentiometer 1 or both with a single command. A one for either P1 or P0 will cause the data to be written to the respective data register and a zero for P1 or P0 will cause no change. See Figure 5-2 for the command format summary.

# 5.3 Using The Shutdown Command

The shutdown command allows the user to put the application circuit into a power saving mode. In this mode, the A terminal is open circuited and the B and W terminals are shorted together. The command select bits C1, C0 are set to 1,0. The potentiometer selection bits P1 and P0 allow each potentiometer to be shutdown independently. If either P1 or P0 are high, the respective potentiometer will enter shutdown mode. A zero for P1 or P0 will have no effect. The eight data bits following the command byte still need to be transmitted for the shutdown command but they are don't care bits. See Figure 5-2 for command format summary. Once a particular potentiometer has entered the shutdown mode, it will remain in this mode until:

• A new value is written to the potentiometer data register, provided that the SHDN pin is high. The device will remain in the shutdown mode until the rising edge of the CS is detected, at which time the device will come out of shutdown mode and the new value will be written to the data register(s). If the SHDN pin is low when the new value is received, the registers will still be set to the new value, but the device will remain in shutdown mode. This scenario assumes that a valid command was received, the command will be ignored and the device will remain in the shutdown mode.

It is also possible to use the hardware shutdown pin and reset pin to remove a device from software shutdown. To do this, a low pulse on the chip select line must first be sent. For multiple devices, sharing a single SHDN or RESET line, allows you to pick an individual device on that chain to remove from software shutdown mode. See Figure 1-3 for timing. With a preceding chip select pulse, either of these situations will also remove a device from software shutdown:

 A falling edge is seen on the RS pin and held low for at least 150ns, provided that the SHDN pin is high. If the SHDN pin is low, the registers will still be set to mid-scale but the device will remain in shutdown mode. This condition assumes that CS is high, as bringing the RS pin low while CS is low is an invalid state and results are indeterminate.

# MCP41XXX/42XXX

- A rising edge on the SHDN pin is seen after being low for at least 100ns, provided that the CS pin is high. Toggling the SHDN pin low while CS is low is an invalid state and results are indeterminate.
- · The device is powered down and back up.

Note: The hardware SHDN pin will always put the device in shutdown regardless of whether a potentiometer has already been put in the shutdown mode using the software command.

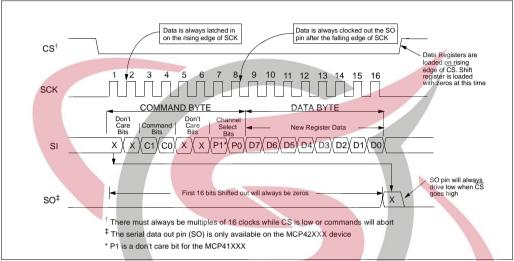


Figure 5-1: Timing Diagram for Writing Instructions or Data to a Digital Potentiometer

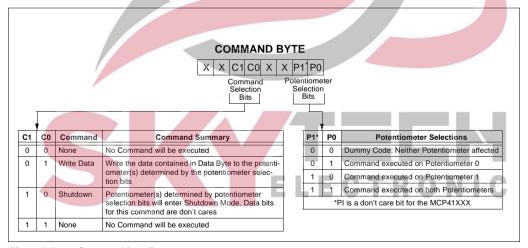


Figure 5-2: Command Byte Format

# 5.4 Daisy-Chain Configuration

Multiple MCP42XXX devices can be connected in a daisy-chain configuration as shown in Figure 5-4, by connecting the SO pin from one device to the SI pin on the next device. The data on the SO pin is the output of the 16-bit shift register. The daisy-chain configuration allows the system designer to communicate with several devices without using a separate CS line for each device. The example shows a daisy chain configuration with three devices, although any number of devices (with or without the same resistor values) can be configured this way. While it is not possible to use a MCP41XXX at the beginning or middle of a daisy-chain because it does not provide the serial data out (SO) pin, it is possible to use the device at the end of a chain. As shown in the timing diagram in Figure 5-3, data will be clocked out of the SO pin on the falling edge of the clock. The SO pin has a CMOS push-pull output and will drive low when CS goes high. SO will not go to a high impedance state when CS is held high.

When using the daisy-chain configuration, the maximum clock speed possible is reduced to ~5.8MHz because of the propagation delay of the data coming out of the SO pin.

When using the daisy-chain configuration, keep in mind that the shift register of each device is automatically loaded with zeros whenever a command is executed  $(\overline{CS} = \text{high})$ . Because of this, the first 16 bits that come out of the SO pin after the CS line goes low will always be zeros. This means that when the first command is being loaded into a device, it will always shift a NOP command into the next device on the chain because the command bits (and all the other bits) will be zeros. This feature makes it necessary only to send command and data bytes to the device farthest down the chain that needs a new command. For example, if there were three devices on the chain and it was desired to send a command to the device in the middle, only 32 bytes of data need to be transmitted. The last device on the chain will have a NOP loaded from the previous device so no registers will be affected when the CS pin is raised to execute the command. The user must always ensure that multiples of 16 clocks are always provided (while CS is low) as all commands will abort if the number of clocks provided is not a multiple of 16.

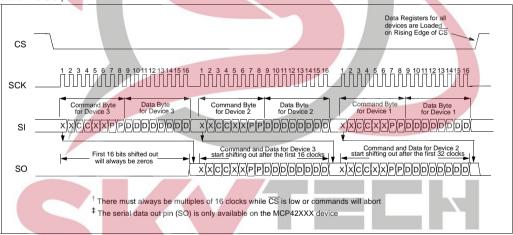


Figure 5-3: Timing Diagram for Daisy-Chain Configuration

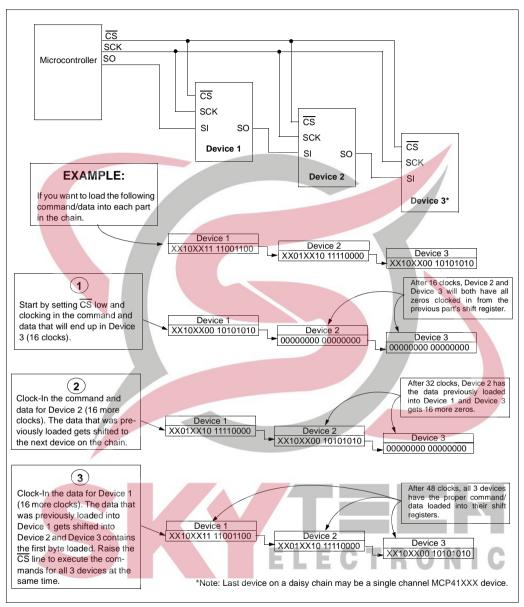


Figure 5-4: Daisy-Chain Configuration

# 5.5 Reset (RS) Pin Operation

The Reset pin  $(\overline{RS})$  will automatically set all potentiometer data latches to mid scale (Code 80h) when pulled low (provided that the pin is held low at least 150ns and  $\overline{CS}$  is high). The reset will execute regardless of the position of the SCK,  $\overline{SHDN}$  and  $\overline{SI}$  pins. It is possible to toggle  $\overline{RS}$  low and back high while  $\overline{SHDN}$  is low. In this case, the potentiometer registers will reset to mid-scale but the potentiometer will remain in shutdown mode until the  $\overline{SHDN}$  pin is raised.

Note: Bringing the RS pin low while the CS pin is low constitutes an invalid operating state and will result in indeterminate results when RS and/or CS are brought high.

# 5.6 Shutdown (SHDN) Pin Operation

When held low, the shutdown pin causes the application circuit to go into a power saving mode by open circuiting the A terminal and shorting the B and W terminals for all potentiometers. Data register contents are not affected by entering shutdown mode, i.e., when the SHDN pin is raised, the data register contents are the same as before the shutdown mode was entered.

While in shutdown mode, it is still possible to clock in new values for the data registers as well as togging the RS pin to cause all data registers to go to mid-scale. The new values will take affect when the SHDN pin is raised

If the device is powered up with the SHDN pin held low, it will power up in the shutdown mode with the data registers set to mid-scale.

Note: Bringing the SHDN pin low while the CS pin is low constitutes an invalid operating state and will result in indeterminate results when SHDN and/or CS are brought high

# 5.7 Power-up Considerations

When the device is powered on, the data registers will be set to mid-scale (80h). A power-on reset circuit is utilized to insure that the device powers up in this known state.

Table 5-1 Truth Table for Logic Inputs

SCK	cs	RS	SHDN	Action
Х	<b>\</b>	I	Н	Communication is initiated with device. Device comes out of standby mode.
L	L	I	Н	No action, device is waiting for data to $\underline{be}$ clocked into shift register or $\overline{CS}$ to go high to execute command.
<b>↑</b>	L	I	Х	Shift one bit into shift register. The shift register can be loaded while the SHDN pin is low.
<b>1</b>		I	X	Shift one bit out of shift register on the SO pin. The SO pin is active while the SHDN pin is low.
X	1	Н	Н	Based on command bits, either load data from shift register into data latches or execute shutdown command. Neither command executed unless multiples of 16 clocks have been entered while CS is low. SO pin goes to a logic low.
X	Н	Н	Н	Static Operation
Х	Н	$\downarrow$	Н	All data registers set and latched to code 80h.
X	Н	+	L	All data registers set and latched to code 80h. Device is in hardware shutdown mode and will remain in this mode.
Х	Н	Н	<b>\</b>	All potentiometers put into hard- ware shutdown mode; terminal A is open and W is shorted to B
X	H	Н	<b>↑</b>	All potentiometers exit hard- ware shutdown mode. Potenti- ometers will also exit software shutdown mode if this rising edge occurs after a low pulse on CS. Contents of data latches are restored.



# 5.8 <u>Using the MCP41XXX/42XXX in SPI</u> Mode 1.1

It is possible to operate the devices in SPI modes 0,0 and 1,1. The only difference between these two modes is that when using mode 1,1 the clock idles in the high state and in mode 0,0 the clock idles in the low state. In both modes, data is clocked into the devices on the rising edge of SCK and data is clocked out the SO pin after the falling edge of SCK. Operations using mode 0,0 are shown in Figure 5-1. The example in Figure 5-5 shows mode 1,1.

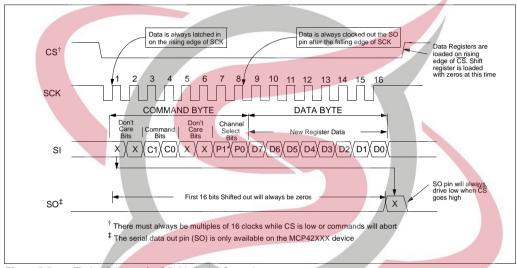
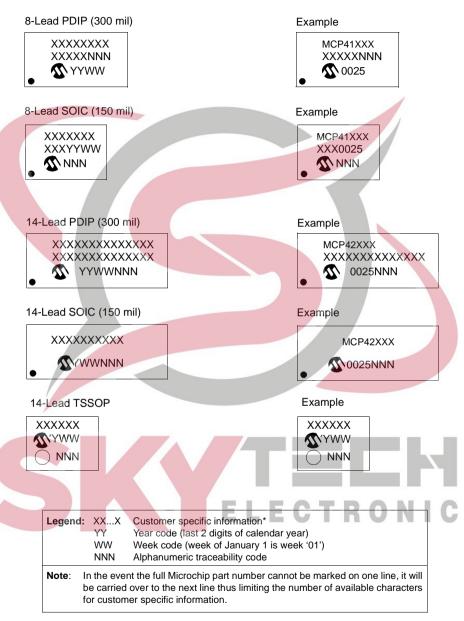


Figure 5-5: Timing Diagram for SPI Mode 1,1 Operation



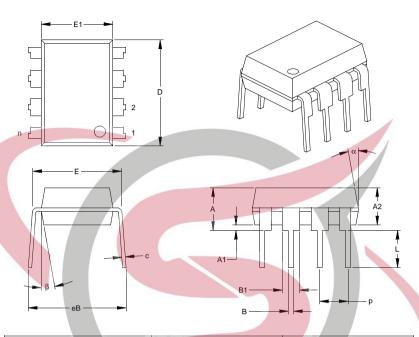
# 6.0 PACKAGING INFORMATION

# 6.1 Package Marking Information



\* Standard OTP marking consists of Microchip part number, year code, week code, facility code, mask rev#, and assembly code. For OTP marking beyond this, certain price adders apply. Please check with your Microchip Sales Office. For QTP devices, any special marking adders are included in QTP price.

# 8-Lead Plastic Dual In-line (P) - 300 mil (PDIP)



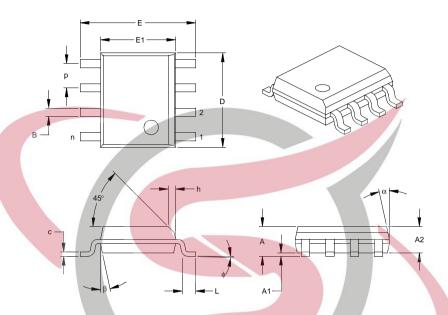
	Units		INCHES*		MILLIMETERS		
Dimension	MIN	NOM	MAX	MIN	NOM	MAX	
Number of Pins	n		8			8	
Pitch	р	No.	.100			2.54	
Top to Seating Plane	Α	.140	.155	.170	3.56	3.94	4.32
Molded Package Thickness	A2	.115	.130	.145	2.92	3.30	3.68
Base to Seating Plane	A1	.015			0.38		
Shoulder to Shoulder Width	E	.300	.313	.325	7.62	7.94	8.26
Molded Package Width	E1	.240	.250	.260	6.10	6.35	6.60
Overall Length	D	.360	.373	.385	9.14	9.46	9.78
Tip to Seating Plane	L	.125	.130	.135	3.18	3.30	3.43
Lead Thickness	С	.008	.012	.015	0.20	0.29	0.38
Upper Lead Width	B1	.045	.058	.070	1.14	1.46	1.78
Lower Lead Width	В	.014	.018	.022	0.36	0.46	0.56
Overall Row Spacing §	eB	.310	.370	.430	7.87	9.40	10.92
Mold Draft Angle Top	α	5	10	15	5	10	15
Mold Draft Angle Bottom	β	5	10	15	5	10	15

<sup>\*</sup> Controlling Parameter § Significant Characteristic

Notes:
Dimensions D and E1 do not include mold flash or protrusions. Mold flash or protrusions shall not exceed .010° (0.254mm) per side.
SEDEC Equivalent: MS-001

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# 8-Lead Plastic Small Outline (SN) - Narrow, 150 mil (SOIC)



	Units		INCHES*		MILLIMETERS			
Dimension	Limits	MIN	NOM	MAX	MIN	NOM	MAX	
Number of Pins	n		8			8		
Pitch	р		.050			1.27		
Overall Height	Α	.053	.061	.069	1.35	1.55	1.75	
Molded Package Thickness	A2	.052	.056	.061	1.32	1.42	1.55	
Standoff §	A1	.004	.007	.010	0.10	0.18	0.25	
Overall Width	Е	.228	.237	.244	5.79	6.02	6.20	
Molded Package Width	E1	.146	.154	.157	3.71	3.91	3.99	
Overall Length	D	.189	.193	.197	4.80	4.90	5.00	
Chamfer Distance	h	.010	.015	.020	0.25	0.38	0.51	
Foot Length	L	.019	.025	.030	0.48	0.62	0.76	
Foot Angle	φ	0	4	8	0	4	8	
Lead Thickness	С	.008	.009	.010	0.20	0.23	0.25	
Lead Width	В	.013	.017	.020	0.33	0.42	0.51	
Mold Draft Angle Top	α	0	12	15	0	12	15	
Mold Draft Angle Bottom	β	0	12	15	0	12	15	

<sup>\*</sup> Controlling Parameter

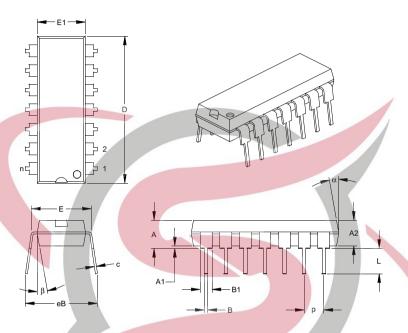
Dimensions D and E1 do not include mold flash or protrusions. Mold flash or protrusions shall not exceed

.010" (0.254mm) per side.

JEDEC Equivalent: MS-012

<sup>§</sup> Significant Characteristic

# 14-Lead Plastic Dual In-line (P) - 300 mil (PDIP)



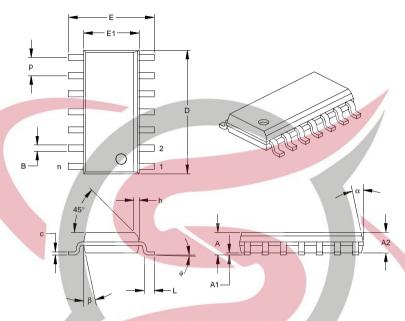
	Units		INCHES*		N	IILLIMETERS	3
Dimension	Limits	MIN	NOM	MAX	MIN	NOM	MAX
Number of Pins	n		14			14	
Pitch	р		.100			2.54	
Top to Seating Plane	Α	.140	.155	.170	3.56	3.94	4.32
Molded Package Thickness	A2	.115	.130	.145	2.92	3.30	3.68
Base to Seating Plane	A1	.015			0.38		
Shoulder to Shoulder Width	Е	.300	.313	.325	7.62	7.94	8.26
Molded Package Width	E1	.240	.250	.260	6.10	6.35	6.60
Overall Length	D	.740	.750	.760	18.80	19.05	19.30
Tip to Seating Plane	L	.125	.130	.135	3.18	3.30	3.43
Lead Thickness	С	.008	.012	.015	0.20	0.29	0.38
Upper Lead Width	B1	.045	.058	.070	1.14	1.46	1.78
Lower Lead Width	В	.014	.018	.022	0.36	0.46	0.56
Overall Row Spacing §	eB	.310	.370	.430	7.87	9.40	10.92
Mold Draft Angle Top	α	5	10	15	5	10	15
Mold Draft Angle Bottom	β	5	10	15	5	10	15
* Controlling Descriptor			The same of	Control of the last of the las	100mm1007		well and the second

<sup>\*</sup> Controlling Parameter § Significant Characteristic

Notes:
Dimensions D and E1 do not include mold flash or protrusions. Mold flash or protrusions shall not exceed

.010" (0.254mm) per side. JEDEC Equivalent: MS-001

# 14-Lead Plastic Small Outline (SL) - Narrow, 150 mil (SOIC)



Dimension Limits   MIN   NOM   MAX   MIN   NOM	MILLIMETERS		
Pitch	MAX		
Overall Height         A         .053         .061         .069         1.35         1.5           Molded Package Thickness         A2         .052         .056         .061         1.32         1.4           Standoff §         A1         .004         .007         .010         0.10         0.           Overall Width         E         .228         .236         .244         5.79         5.9           Molded Package Width         E1         .150         .154         .157         3.81         3.3	4		
Molded Package Thickness         A2         .052         .056         .061         1.32         1.4           Standoff §         A1         .004         .007         .010         0.10         0.           Overall Width         E         .228         .236         .244         5.79         5.9           Molded Package Width         E1         .150         .154         .157         3.81         3.9	7		
Standoff         §         A1         .004         .007         .010         0.10         0.           Overall Width         E         .228         .236         .244         5.79         5.5           Molded Package Width         E1         .150         .154         .157         3.81         3.5	5 1.75		
Overall Width         E         .228         .236         .244         5.79         5.9           Molded Package Width         E1         .150         .154         .157         3.81         3.9	2 1.55		
Molded Package Width E1 .150 .154 .157 3.81 3.9	8 0.25		
-	9 6.20		
Overall Length D .337 .342 .347 8.56 8.6	0 3.99		
	9 8.81		
Chamfer Distance         h         .010         .015         .020         0.25         0.3	8 0.51		
Foot Length L .016 .033 .050 0.41 0.8	4 1.27		
Foot Angle   0 4 8 0	4 8		
Lead Thickness c .008 .009 .010 0.20 0.2	3 0.25		
Lead Width B .014 .017 .020 0.36 0.4	2 0.51		
Mold Draft Angle Top α 0 12 15 0	215		
Mold Draft Angle Bottom β 0 12 15 0	2 15		

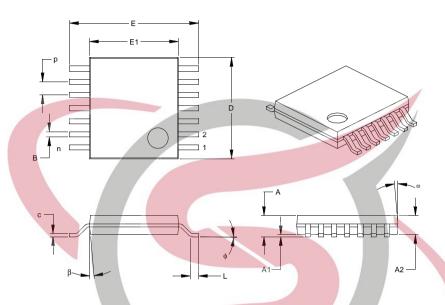
# Notes:

Dimensions D and E1 do not include mold flash or protrusions. Mold flash or protrusions shall not exceed

.010" (0.254mm) per side.
JEDEC Equivalent: MS-012

<sup>\*</sup> Controlling Parameter § Significant Characteristic

# 14-Lead Plastic Thin Shrink Small Outline (ST) - 4.4 mm (TSSOP)



	Units		INCHES		N	<b>MILLIMETERS</b>	S*
Dimensio	n Limits	MIN	NOM	MAX	MIN	NOM	MAX
Number of Pins	n		14			14	
Pitch	р		.026			0.65	
Overall Height	A	277		.043		4	1.10
Molded Package Thickness	A2	.033	.035	.037	0.85	0.90	0.95
Standoff §	A1	.002	.004	.006	0.05	0.10	0.15
Overall Width	Е	.246	.251	.256	6.25	6.38	6.50
Molded Package Width	E1	.169	.173	.177	4.30	4.40	4.50
Molded Package Length	D	.193	.197	.201	4.90	5.00	5.10
Foot Length	L	.020	.024	.028	0.50	0.60	0.70
Foot Angle	ф	0	4	8	0	4	8
Lead Thickness	C	.004	.006	.008	0.09	0.15	0.20
Lead Width	B1	.007	.010	.012	0.19	0.25	0.30
Mold Draft Angle Top	α	0	5	10	0	5	10
Mold Draft Angle Bottom	β	0	_5	10	0	5	_10
* Controlling Parameter	\ ·				100		

<sup>\*</sup> Controlling Parameter § Significant Characteristic

Notes:

Dimensions D and E1 do not include mold flash or protrusions. Mold flash or protrusions shall not exceed .005" (0.127mm) per side.

JEDEC Equivalent: MO-153

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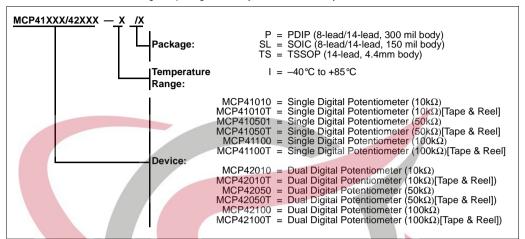
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